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Gormley et al. APPLICANT

09/14/2000

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VU, Quang D **EXAMINER**

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

1AY 0 2 2003

FILING DATE

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
91	AA	6,064,081	05/16/2000	Robinson et al.			01/15/1998
9V	AB	5,760,443	06/02/1998	McCarthy			10/23/1995
av	AC	5,629,790	05/13/1997	Neukermans et al.			10/18/1993
qV	AD	4,614,119	09/30/1986	Zavracky et al.			03/08/19985
	AE						
	AF						
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	: SUBCLASS	TRANSLATION YES NO
gV	AG	2,275,787	09/07/1994	UK	,	•	YES
	АН					· .	
_	AI	OTUED	OCUMENTS	Goolyding Author Title Dat	a Partinant E	Pages Fite)	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) EXAMINER							
INITIAL							
9V	AJ	"Evaluation of Wafer Bonding and Etch Back for SOI Technology," Baumgart et A Philips Journal of Research. 1995. Vol. 49, No. ½.					
gV	AK	"Micromachined Widely Tunable Vertical Cavity Laser Diodes," Sugihwo et al. Journal of Microelectromechanical Systems. March 1998. Vol. 7, No. 1.					
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	АМ	VEI 2003					
	AN				· · ·	2800	
	AO					<u></u>	

EXAMINER

DATE CONSIDERED

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Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.